

# FMOS6041K

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# FMOS6041K

## -200mA, -60V P-Channel Enhancement Mode MOSFET

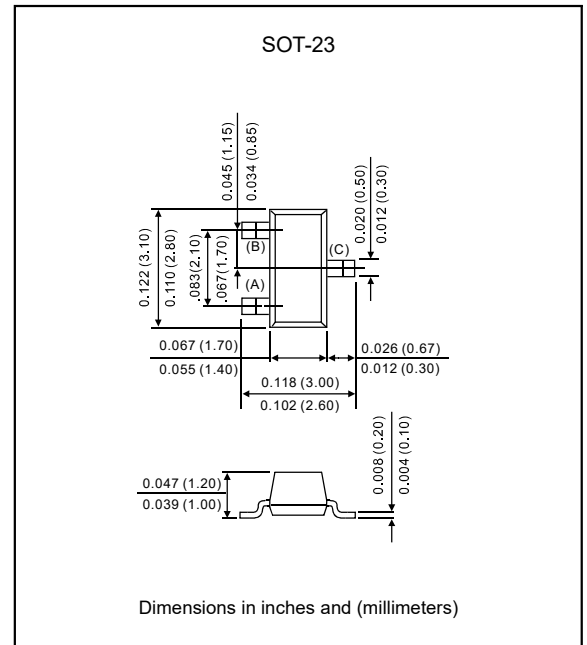
### Features

- $-V_{DS} = 60V, -I_D = 200mA.$
- $R_{DS(ON)} \leq 5.0\Omega, @-V_{GS}=10V, -I_D=200mA.$
- $R_{DS(ON)} \leq 5.5\Omega, @-V_{GS}=4.5V, -I_D=100mA.$
- ESD Protected 2KV (Human body mode).
- Reliable and rugged.
- RoHs compliant & Halogen - Free.
- Suffix "-H" indicates Halogen-free part, ex.FMOS6041K-H.

### Mechanical data

- Epoxy:UL94-V0 rated flame retardant
- Case : Molded plastic, SOT-23
- Terminals : Solder plated, solderable per MIL-STD-750, Method 2026
- Mounting Position : Any
- Weight : Approximated 0.008 gram

### Package outline



### Maximum ratings ( $T_A=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Ratings	Unit
Drain-source voltage	$-V_{DS}$	60	V
Gate-source voltage	$V_{GS}$	$\pm 20$	V
Continuous drain current ( $T_A=25^\circ C$ )	$-I_D$	200	mA
( $T_A=100^\circ C$ )		120	
Pulsed drain current ( $T_A=25^\circ C$ , Note 1)	$-I_{DM}$	900	mA
Power dissipation ( $T_A=25^\circ C$ )	$P_D$	360	mW
( $T_A=100^\circ C$ )		230	
Thermal resistance form junction to ambient	$R_{\theta JA}$	350	$^\circ C/W$
Operating Junction temperature range	$T_J$	+150	$^\circ C$
Storage temperature range	$T_{STG}$	-40 to +150	$^\circ C$

## FMOS6041K

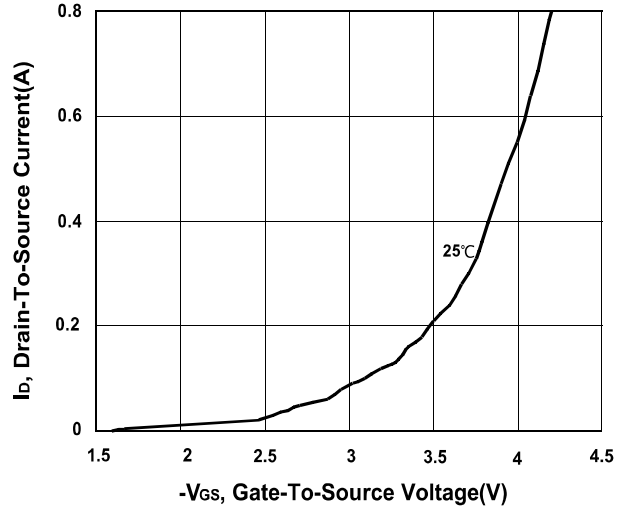
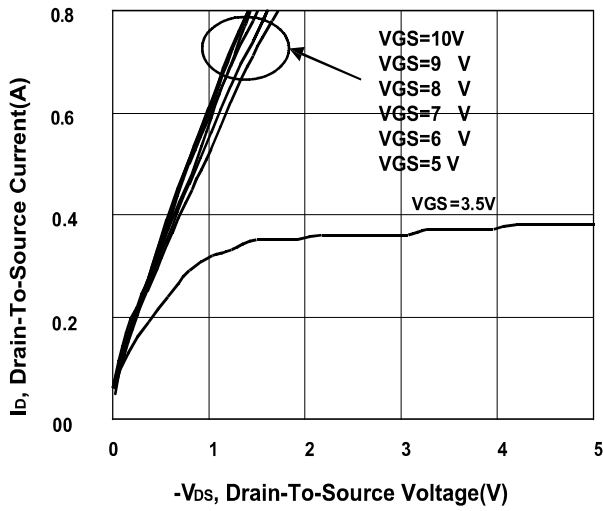
Electrical characteristics (At  $T_j=25^{\circ}\text{C}$  unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
<b>Off characteristics</b>						
Drain-source breakdown voltage	$-BV_{DSS}$	$-I_D=250\mu\text{A}, V_{GS}=0\text{V}$	60			V
Drain-source leakage current	$-I_{DSS}$	$-V_{DS}=48\text{V}, V_{GS}=0\text{V}$			1	$\mu\text{A}$
Gate-source leakage current	$I_{GSS}$	$V_{GS}=\pm 16\text{V}, V_{DS}=0\text{V}$			$\pm 30$	$\mu\text{A}$
<b>On characteristics</b>						
Gate threshold voltage	$-V_{GS(TH)}$	$V_{DS}=V_{GS}, -I_D=250\mu\text{A}$	1.0	1.6	2.5	V
Static drain-source on-resistance (Note 1)	$R_{DS(ON)}$	$-V_{GS}=3.5\text{V}, -I_D=10\text{mA}$		5.2	6.0	$\Omega$
		$-V_{GS}=4.5\text{V}, -I_D=100\text{mA}$		4.5	5.5	
		$-V_{GS}=10\text{V}, -I_D=200\text{mA}$		4.0	5.0	
Forward Transconductance	$g_{FS}$	$-V_{GS}=5\text{V}, -I_D=100\text{mA}$		4.4		S
<b>Dynamic Parameters (Note 5)</b>						
Input capacitance	$C_{iss}$	$V_{GS}=0\text{V}, -V_{DS}=25\text{V}, f=1.0\text{MHz}$		27.7		pF
Output capacitance	$C_{oss}$			17.3		
Reverse transfer capacitance	$C_{rss}$			7.5		
<b>Switching parameters</b>						
Total gate charge	$Q_g$	$-V_{GS}=10\text{V}, -V_{DS}=30\text{V}, -I_D=200\text{mA}$		0.84		nC
Gate to source charge	$Q_{gs}$			0.19		
Gate to Drain charge	$Q_{gd}$			0.21		
<b>Source-drain diode ratings and characteristics</b>						
Continuous current	$-I_s$			200		mA
Drain - source diode forward voltage (Note 1)	$-V_{SD}$	$-V_{GS}=0\text{V}, -I_s=200\text{mA}$		0.85	1.2	V

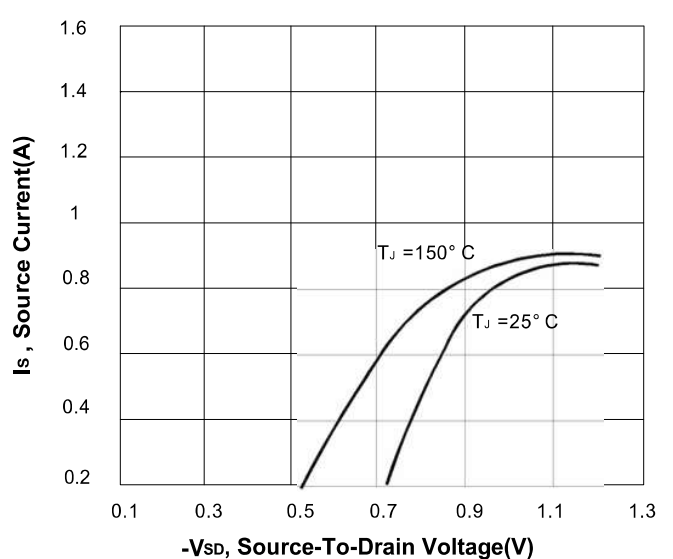
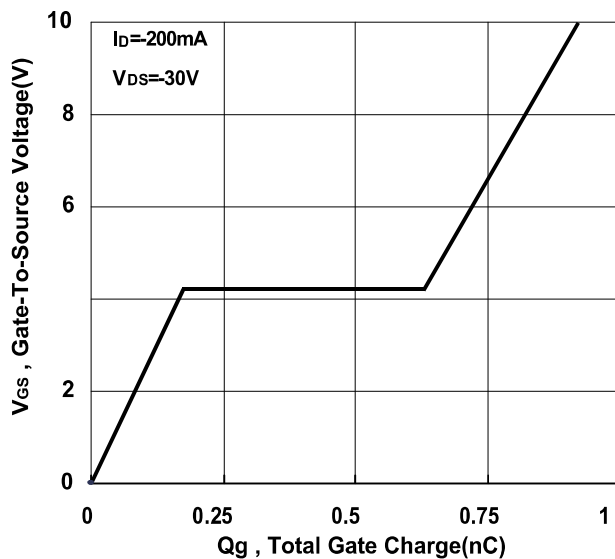
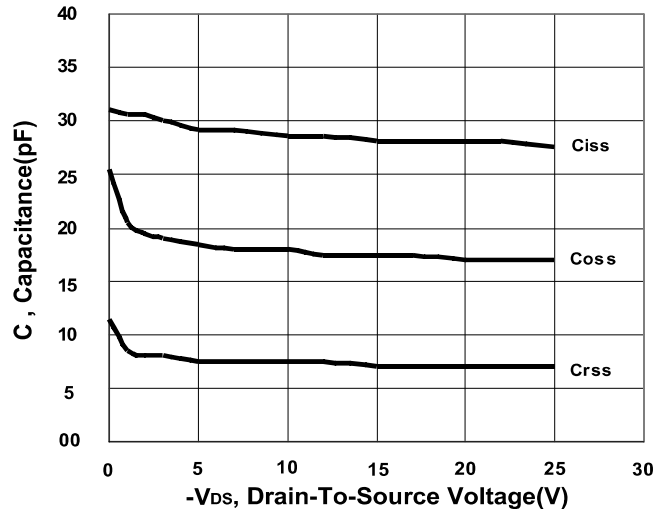
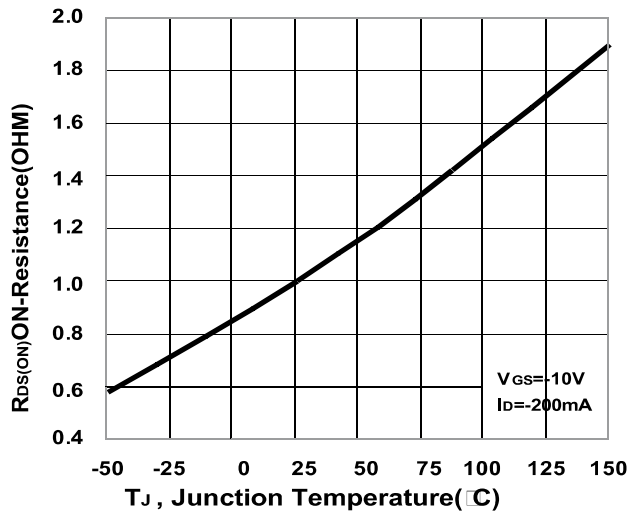
- Note : 1. Pulse test : Pulse width  $\leq 300 \mu\text{sec}$ , duty cycle  $\leq 2\%$ ..  
 2. Independent of operating temperature.  
 3. Pulse width limited by maximum junction temperature.

# FMOS6041K

## Rating and characteristic curves

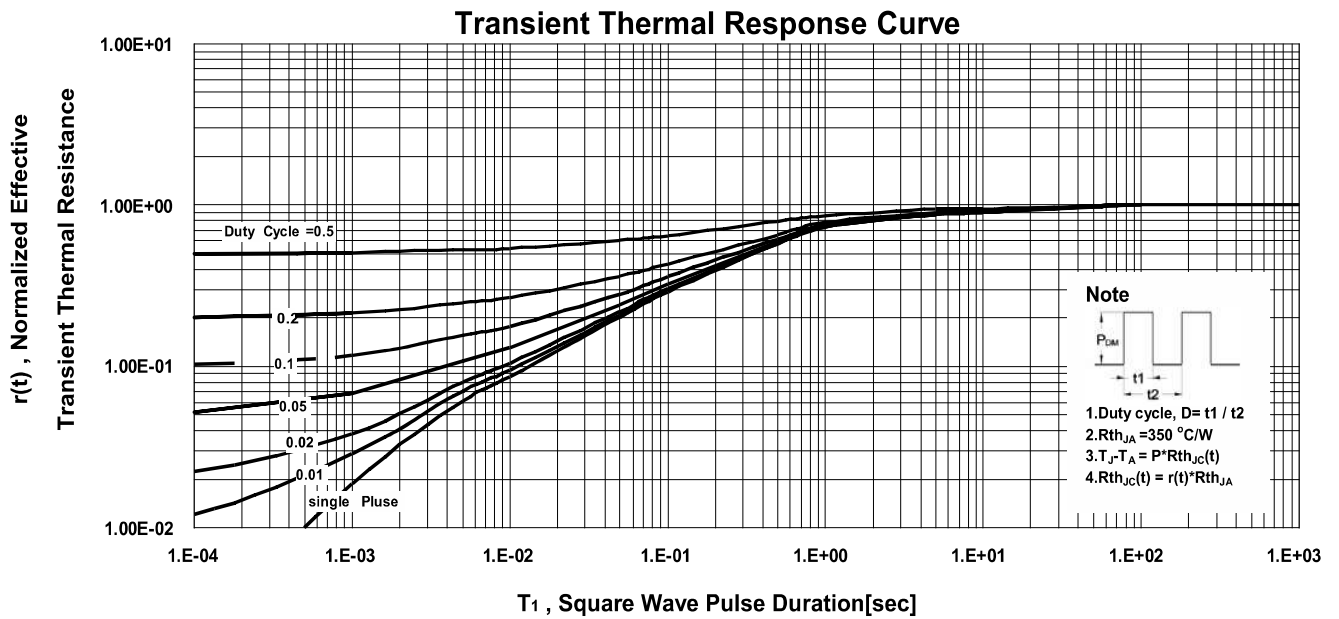
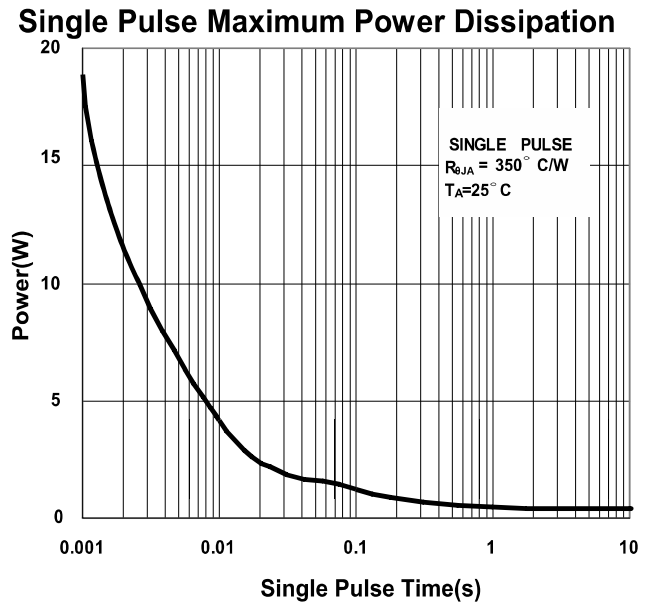
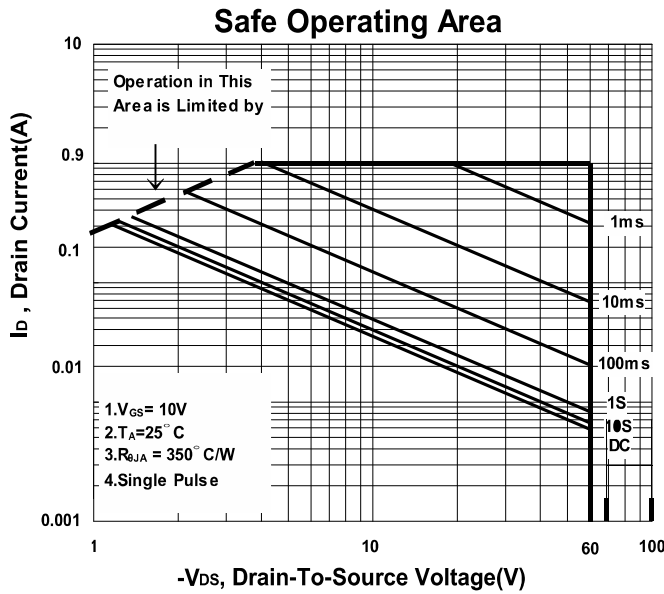


### Capacitance Characteristic



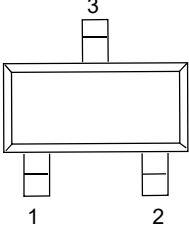
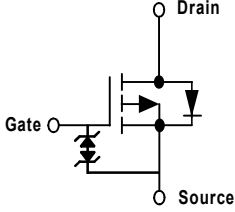
# FMOS6041K

## Rating and characteristic curves

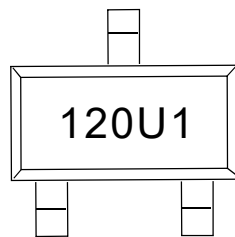


# FMOS6041K

## Pinning information

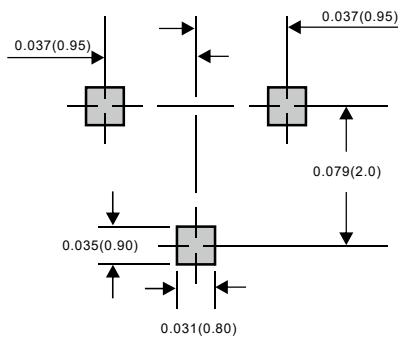
Pin	Simplified outline	Symbol
Pin 1 Gate Pin 2 Source Pin 3 Drain		

## Marking



## Suggested solder pad layout

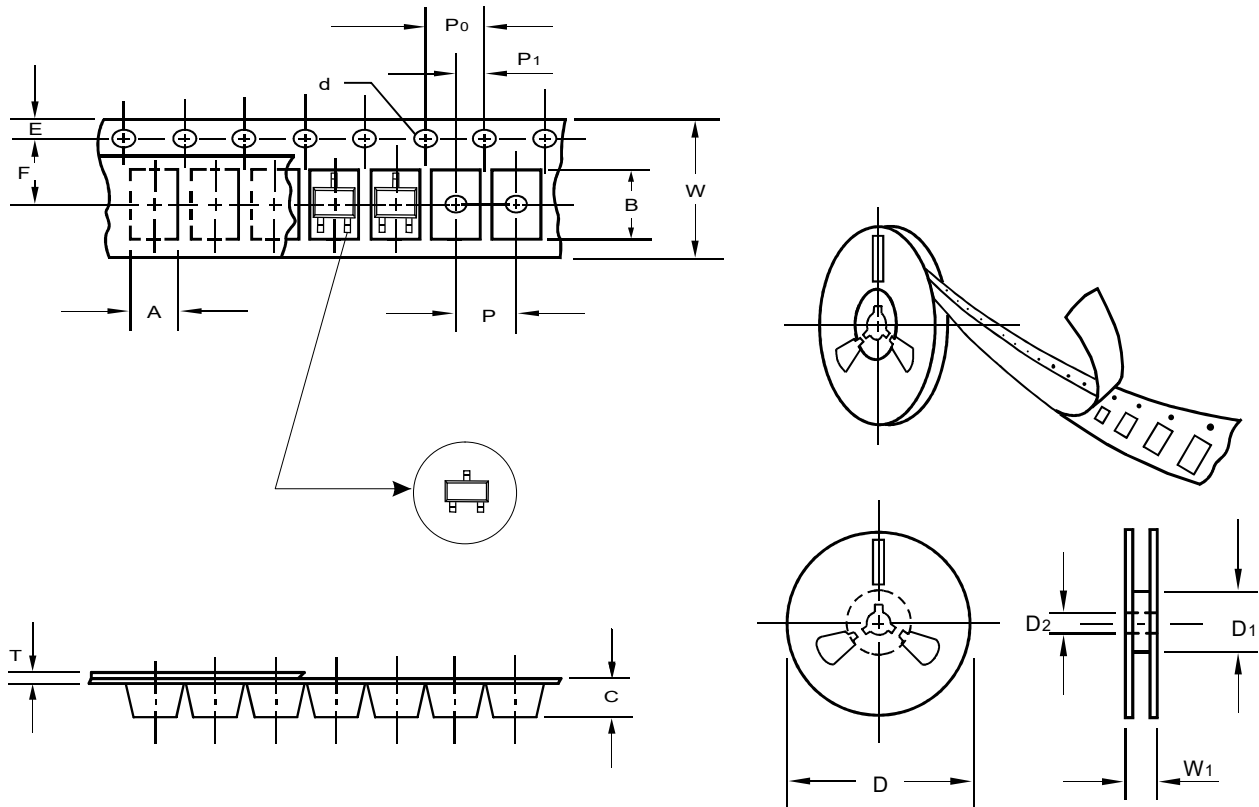
### SOT-23



Dimensions in inches and (millimeters)

# FMOS6041K

## Packing information



unit:mm

Item	Symbol	Tolerance	SOT-23
Carrier width	A	0.1	3.15
Carrier length	B	0.1	2.77
Carrier depth	C	0.1	1.22
Sprocket hole	d	0.1	1.50
13" Reel outside diameter	D	2.0	-
13" Reel inner diameter	D1	min	-
7" Reel outside diameter	D	2.0	178.00
7" Reel inner diameter	D1	min	54.40
Feed hole diameter	D2	0.5	13.00
Sprocket hole position	E	0.1	1.75
Punch hole position	F	0.1	3.50
Punch hole pitch	P	0.1	4.00
Sprocket hole pitch	P0	0.1	4.00
Embossment center	P1	0.1	2.00
Overall tape thickness	T	0.1	0.23
Tape width	W	0.3	8.00
Reel width	W1	1.0	11.40

Note: Devices are packed in accordance with EIA standard RS-481-A and specifications listed above.

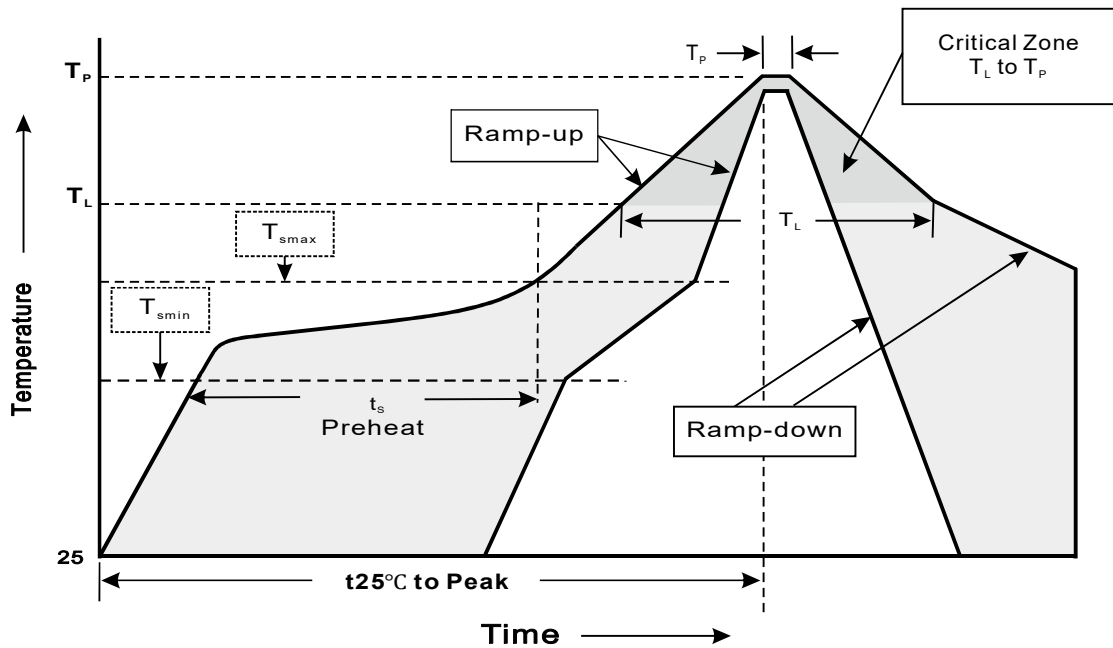
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## Reel packing

PACKAGE	REEL SIZE	REEL (pcs)	COMPONENT SPACING (m/m)	BOX (pcs)	INNER BOX (m/m)	REEL DIA, (m/m)	CARTON SIZE (m/m)	CARTON (pcs)	APPROX. GROSS WEIGHT (kg)
SOT-23	7"	3,000	4.0	30,000	183*123*183	178	382*257*387	240,000	11.6

## Suggested thermal profiles for soldering processes

- 1.Storage environment: Temperature=5°C~40°C Humidity=55%±25%
- 2.Reflow soldering of surface-mount devices



### 3.Reflow soldering

Profile feature	Soldering Condition
Average ramp-up rate ( $T_L$ to $T_P$ )	< 3°C/sec
Preheat -Temperature Min ( $T_{smin}$ ) -Temperature Max ( $T_{smax}$ ) -Time (min to max) ( $t_s$ )	150°C 200°C 60 ~ 120sec
$T_{smax}$ to $T_L$ -Ramp-up rate	< 3°C/sec
Time maintained above: -Temperature ( $T_L$ ) -Time( $T_L$ )	217°C 60 ~ 260 sec
Peak Temperature( $T_P$ )	255°C -0/+5°C
Time within 5°C of actual peak Temperature( $T_P$ )	10 ~ 30sec
Ramp-down rate	< 6°C/sec
Time 25°C to peak temperature	< 6 minutes